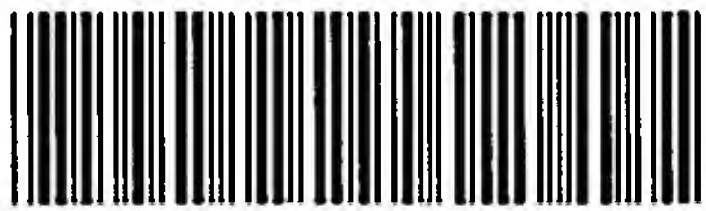


Search Notes (continued)



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,436	CROUCH ET AL.	
Examiner	Art Unit	
Jay M. Patidar	2862	

SEARCHED			
Class	Subclass	Date	Examiner
324	219	2/10/2005	JP
—	220		
	228		
—	209		
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— 73	592		
	598		
	600		
	622		
	623		
	643		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searched.	2/10/2005	JP